



Product data sheet

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SOD-' 23



BAT46WG SCHOTTKY BARRIER DIODE

FEATURES

- High breakdown voltage
- Low turn-on voltage
- Guard ring construction for transient protection

Maximum Ratings @T₂=25℃

| Parameter | Symbol | Limit | Unit |
|--|-----------------------|------------|------|
| Peak repetitive peak reverse voltage | | 100 | V |
| Working peak reverse voltage | V _{RWM} | 100 | v |
| Forward continuous current | l _F | 150 | mA |
| Repetitive peak forward current (Note 1) @ tp < 1.0s, Duty Cycle < 50% | I _{FRM} | 350 | mA |
| Non-repetitive Peak Forward surge current @ t = 8.3ms | I _{FSM} | 750 | mA |
| Power dissipation | PD | 200 | mW |
| Thermal resistance junction to ambient air | $R_{	extsf{	heta}JA}$ | 500 | °C/W |
| Operating Junction Temperature Range | Tj | -40 ~ +125 | °C |
| Storage Temperature Range | T _{STG} | -55 ~ +150 | °C |

ELECTRICAL CHARACTERISTICS (Ta=25°C unless otherwise specified)

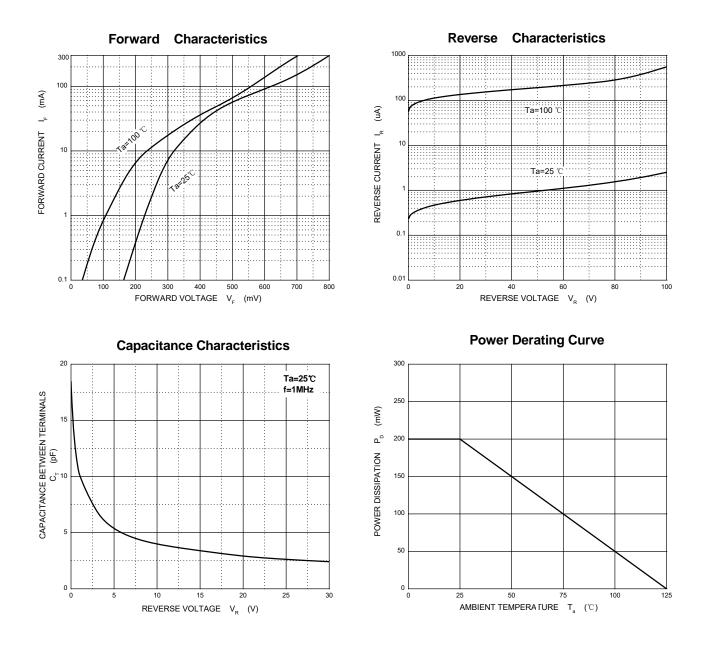
| Parameter | Symbol | Test Conditions | Min | Тур | Max | Unit | |
|-----------------------------------|----------------|----------------------------|-----|-----|------|------|--|
| Reverse breakdown voltage(Note 2) | V _R | Ι _R = 100μΑ | 100 | | | V | |
| Reverse voltage leakage current | I _R | V _{R1} =1.5V | | | 0.3 | | |
| | | V _{R2} =10V | | | 0.5 | μA | |
| | | V _{R3} =50V | | | 1 | | |
| | | V _{R4} =75V | | | 2 | | |
| | VF | I _{F1} =0.1mA | | | 0.25 | V | |
| Forward voltage(Note 2) | | I _{F2} =10mA | | | 0.45 | | |
| | | I⊧₃=250mA | | | 1 | | |
| | | V _R =0, f=1MHz | | 20 | | _ | |
| Diode capacitance | CT | V _R =1V, f=1MHz | | 12 | | pF | |

Notes: 1. Part mounted on FR-4 board with recommended pad layout.

2. Short duration pulse test used to minimize self-heating effect.

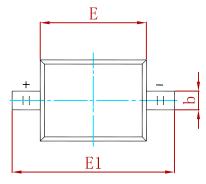


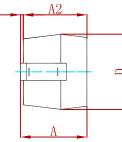




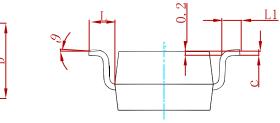


PACKAGE MECHANICAL DATA



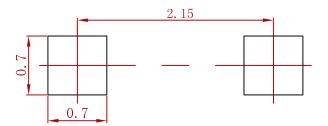


<u>A1</u>



| Dimensions In Millimeters | | Dimensions In Inches | | |
|---------------------------|------------|----------------------|------------|-------|
| Symbol | Min. | Max. | Min. | Max. |
| A | | 1.000 | | 0.039 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| A2 | 0.800 | 0.900 | 0.031 | 0.035 |
| b | 0.250 | 0.350 | 0.010 | 0.014 |
| с | 0.080 | 0.150 | 0.003 | 0.006 |
| D | 1.200 | 1.400 | 0.047 | 0.055 |
| E | 1.600 | 1.800 | 0.063 | 0.071 |
| E1 | 2.550 | 2.750 | 0.100 | 0.108 |
| L | 0.475 REF. | | 0.019 REF. | |
| L1 | 0.250 | 0.400 | 0.010 | 0.016 |
| θ | 0° | 8° | 0° | 8° |

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.

3. The pad layout is for reference purposes only.

REEL SPECIFICATION

| P/N | PKG | QTY |
|---------|---------|------|
| BAT46WS | SOD-323 | 3000 |





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